## Search Notes



	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10592959	TAKEZAWA, HIDEHARU	
	Examiner	Art Unit	
	JACOB BUCHANAN	1795	

SEARCHED			
Class	Subclass	Date	Examiner
429	122-225	4/28/2009	EAN
	updated above class/subclass search	12/3/2009	jb

SEARCH NOTES		
Search Notes	Date	Examiner
EAST text search, see search history	4/29/2009	EAN
PLUS search	3/9/2009	EAN
Google search: mAh, milliamp hour	4/28/2009	EAN
Inventor name search, PALM	4/29/2009	EAN
Updated EAST text search, see search history	12/3/2009	jb
Updated Inventor name search, eDan	12/3/2009	jb

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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